

Notice of References Cited	Application/Control No. 10/563,181	Applicant(s)/Patent Under Reexamination MILIAN LAMPIC-OPLANDER	
	Examiner Deborah Yee	Art Unit 1793	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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	U	Derwent publication 1976-80554X, English abstract of NL 150847, September 15, 1976.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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